



CALIBRATION LABORATORIES

NVLAP LAB CODE 200405-0

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005

<p>Dwight Calibration & Instrument LLC 10 Stuyvesant Avenue Lyndhurst, NJ 07071-0909 Mrs. Carolyn Howe Phone: 201-438-3334 Fax: 201-438-0594 E-mail: chowe@dwightcalibration.com URL: http://www.dwightcalibration.com</p>	<p>Parameter(s) of Accreditation Dimensional Mechanical</p> <p>This laboratory is compliant to ANSI/NC SL Z540-1-1994; Part 1. (NVLAP Code: 20/A01)</p>
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CALIBRATION AND MEASUREMENT CAPABILITIES (CMC) ^{Notes 1,2}

Measured Parameter or Device Calibrated	Range	Uncertainty ($k=2$) ^{Note 3}	Remarks
DIMENSIONAL			
NVLAP Code: 20/D03 GAGE BLOCKS			
Steel	0 in to 4 in	Where L is the length in inches. $3.5 \mu\text{in} + 2L \mu\text{in}$	
NVLAP Code: 20/D05 LENGTH & DIAMETER; STEP GAGES			All items in section have field service available ^{Note 4}
Micrometers	> 0 in to 24 in	Where L is the length in inches. $40 \mu\text{in} + 2L \mu\text{in}$	
Dial Indicators	> 0 in to 2 in	50 μin	
Optical Comparators Calipers	> 0 in to 8 in > 0 in to 36 in	150 μin $85 \mu\text{in} + 2L \mu\text{in}$	
NVLAP Code: 20/D07 MEASURING WIRES			
Thread Measuring Wires	Up to 80 pitch	24 μin	Light Wave Micrometer
NVLAP Code: 20/D11 SPHERICAL DIAMETER; PLUG/RING GAGES			
Spherical Diameter – Plain Rings	> 0 in to 8 in	Where L is the length in inches. $50 \mu\text{in} + 5L \mu\text{in}$	
Plain Plugs	> 0 in to 2 in > 2 in to 4 in	24 μin 30 μin	Lightwave Supermicrometer

2011-10-01 through 2012-09-30
Effective dates

Sally S. Bruce

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CALIBRATION AND MEASUREMENT CAPABILITIES (CMC) ^{Notes 1,2}

Measured Parameter or Device Calibrated	Range	Uncertainty ($k=2$) ^{Note 3}	Remarks
NVLAP Code: 20/D12 SURFACE TEXTURE Granite Surface Plates	Up to 12 ft Up to 12 ft	In lab and field service 50 μ in per ft 30 μ in per ft	Rhan and autocollimator Leveltronics
NVLAP Code: 20/D14 THREADED PLUG & RING GAGES Threaded Plug Gages – Pitch Diameter Threaded Ring Gages – Functional Diameter	> 0 in to 4 in > 0 in to 4 in	100 μ in 100 μ in	
NVLAP Code: 20/D16 COORDINATE MEASURING MACHINES Repeatability Volumetric Linearity	 > 0 in to 19 in > 19 in to 26 in > 26 in to 37 in > 37 in to 74 in	25 μ in 160 μ in Where L is the length in inches. 20 μ in + 13 L μ in 260 μ in + 6.5 L μ in 420 μ in + 3 L μ in 520 μ in + 19 L μ in	
MECHANICAL			
NVLAP Code: 20/M15 TORQUE Torque Wrenches	> 0 in-oz to 50 in-oz > 0 in-lb to 30 in-lb > 0 in-lb to 600 in-lb > 0 ft-lb to 250 ft-lb	1.0 % 1.0 % 1.0 % 1.0 %	Compared to transducers
END			

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Notes

Note 1: A Calibration and Measurement Capability (CMC) is a description of the best result of a calibration or measurement (result with the smallest uncertainty of measurement) that is available to the laboratory's customers under normal conditions, when performing more or less routine calibrations of nearly ideal measurement standards or instruments. The CMC is described in the laboratory's scope of accreditation by: the measurement parameter/device being calibrated, the measurement range, the uncertainty associated with that range (see note 3), and remarks on additional parameters, if applicable.

Note 2: Calibration and Measurement Capabilities are traceable to the national measurement standards of the U.S. or to the national measurement standards of other countries and are thus traceable to the internationally accepted representation of the appropriate SI (Système International) unit.

Note 3: The uncertainty associated with a measurement in a CMC is an expanded uncertainty using a coverage factor, $k = 2$, with a level of confidence of approximately 95 %. Units for the measurand and its uncertainty are to match. Exceptions to this occur when marketplace practice employs mixed units, such as when the artifact to be measured is labeled in non-SI units and the uncertainty is given in SI units (Example: 5 lb weight with uncertainty given in mg).

Note 3a: The uncertainty of a specific calibration by the laboratory may be greater than the uncertainty in the CMC due to the condition and behavior of the customer's device and specific circumstances of the calibration. The uncertainties quoted do not include possible effects on the calibrated device of transportation, long term stability, or intended use.

Note 3b: As the CMC represents the best measurement results achievable under normal conditions, the accredited calibration laboratory shall not report smaller uncertainty of measurement than that given in a CMC for calibrations or measurements covered by that CMC.

Note 3c: As described in Note 1, CMCs cover calibrations and measurements that are available to the laboratory's customers under *normal conditions*. However, the laboratory may have the capability to offer special tests, employing special conditions, which yield calibration or measurement results with lower uncertainties. Such special tests are not covered by the CMCs and are outside the laboratory's scope of accreditation. In this case, NVLAP requirements for the labeling, on calibration reports, of results outside the laboratory's scope of accreditation apply. These requirements are set out in Annex A.1.h. of NIST Handbook 150, Procedures and General Requirements.

Note 4: Uncertainties associated with field service calibration may be greater as they incorporate on-site environmental contributions, transportation effects, or other factors that affect the measurements. (This note applies only if marked in the body of the scope.)

Note 5: Values listed with percent (%) are percent of reading or generated value unless otherwise noted.

Note 6: NVLAP accreditation is the formal recognition of specific calibration capabilities. Neither NVLAP nor NIST guarantee the accuracy of individual calibrations made by accredited laboratories.

Note 7: See [NIST Handbook 150](#) for further explanation of these notes.

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